

# LH0044 Series Precision Low Noise Operational Amplifiers

### **General Description**

The LH0044 Series is a low noise, ultra-stable, high gain, precision operational amplifier family intended to replace either chopper-stabilized monolithic or modular amplifiers. The devices are particularly suited for differential mode, inverting, and non-inverting mode applications requiring very low initial offset, low offset drift, very high gain, high CMRR, and high PSRR. In addition, the LH0044 Series' low initial offset and offset drift eliminate costly and time consuming null adjustments at the systems level. The superior performance afforded by the LH0044 Series is made possible by advanced processing and testing techniques, as well as active laser trim of critical metal film resistors to minimize offset voltage and drift. Unique construction eliminates thermal feedback effects.

The LH0044 Series is an excellent choice for a wide range of precision applications including strain gauge bridges, thermocouple amplifiers, and ultrastable reference ampli-

fers. The LH0044 is guaranteed over the temperature range of  $-55^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ , and the LH0044AC, LH0044B, and LH0044C are guaranteed from  $-25^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ . The device is available in standard TO-5 op amp pin out and is compatible with LM108A, LM725, and LM741 type amplifiers.

### **Features**

■ Low input offset voltage 25µV max ■ Excellent long-term stability ±1µV/month max

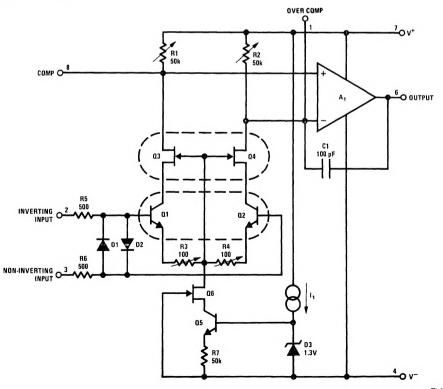
■ Low offset drift 0.5µV/°C max

■ Very low noise 0.7µVp-p max 0.1 Hz to 10 Hz
■ High CMRR and PSRR 120 dB min

■ High open loop gain 120 dB min
■ Wide common-mode range ± 13V min

■ Wide supply voltage range ±2V to ±20V

### **Equivalent Circuit**



TL/K/5551-1

### **Absolute Maximum Ratings**

If Military/Aerospace specified devices are required, contact the National Semiconductor Sales Office/Distributors for availability and specifications. (Note 6)

 Supply Voltage
 ± 20V

 Power Dissipation
 600 mW

 Differential Input Voltage (Note 4)
 ± 1V

Input Voltage (Note 5) ±15V

Output Short-Circuit Duration Operating Temperature Range

LH0044 LH0044AC, LH0044B, LH0044C Storage Temperature Range -55°C to +125°C -25°C to +85°C -65°C to +150°C 260°C

Continuous

Lead Temperature (Soldering, 10 sec.) ESD rating to be determined.

### **DC Electrical Characteristics** (Note 1)

| Parameter                             | Conditions   | Limits   |                      |                            |     |                      | 1           |                |
|---------------------------------------|--|----------|----------------------|----------------------------|-----|----------------------|-------------|----------------|
|                                       |  | LH0044AC |                      | LH0044/<br>LH0044B/LH0044C |     |                      | Units       |                |
|                                       |  | Min      | Тур                  | Max                        | Min | Тур                  | Max         |                |
| Input Offset Voltage                  | $T_A$ =25°C, $R_S$ =50 $\Omega$ , $V_{CM}$ =0V<br>LH0044C Only   |          | 8                    | 25                         |     | 12                   | 50<br>100   | μV<br>μV       |
| Input Offset Voltage                  | $R_S = 50\Omega$ , $V_{CM} = 0V$<br>LH0044A and LH0044B Only   |          |                      | 55<br>75                   |     |                      | 180<br>80   | μV<br>μV       |
| Average Input Offset<br>Voltage Drift | T <sub>Min</sub> ≤ T <sub>A</sub> ≤ T <sub>Max</sub><br>LH0044B Only   |          | 0.1                  | 0.5                        |     | 0.2                  | 1.3<br>0.5  | μV/°C<br>μV/°C |
| Long-Term Stability                   | (Note 2)   |          | 0.2                  | 1                          |     | 0.3                  | 2           | μV/month       |
| Input Noise Voltage (Note 3)          | BW = 0.1 Hz to 10 Hz, R <sub>S</sub> = $50\Omega$<br>R <sub>S</sub> = $10 \text{ k}\Omega$ Imbalance   |          | 0.35<br>0.50         | 0.7<br>0.9                 |     | 0.35<br>0.50         | 0.8<br>1.0  | μVp-p<br>μVp-p |
| Thermal Feedback Coefficient          |  |          | 0.005                |                            |     | 0.005                |             | μV/mW          |
| Open Loop Voltage Gain                | $R_L = 10  k\Omega$  | 120      | 145                  |                            | 114 | 140                  |             | dB             |
| Common-Mode Rejection Ratio           | $-10V \le V_{CM} \le +10V$   | 120      | 145                  |                            | 114 | 140                  |             | dB             |
| Power Supply Rejection Ratio          | $\pm 3V \le V_S \le \pm 18V$   | 120      | 145                  |                            | 114 | 140                  |             | dB             |
| Input Voltage Range                   |  | ±13      | ± 13.8               |                            | ±12 | ± 13.5               |             | V              |
| Output Voltage Swing                  | $R_L = 10  k\Omega$  | ± 13     | ±13.7                |                            | ±12 | ± 13.5               |             | ٧              |
| Input Offset Current                  | $25^{\circ}\text{C} \le \text{T}_{\text{A}} \le \text{T}_{\text{Max}}$<br>$\text{T}_{\text{Min}} \le \text{T}_{\text{A}} < 25^{\circ}\text{C}$ |          | 1.0                  | 2.5<br>5.0                 |     | 1.5                  | 5.0<br>10.0 | nA<br>nA       |
| Average Input Offset<br>Current Drift |  |          | 5                    | 40                         |     | 15                   | 80          | pA/°C          |
| Input Bias Current                    | 25°C ≤ T <sub>A</sub> ≤ T <sub>Max</sub><br>T <sub>Min</sub> ≤ T <sub>A</sub> < 25°C   |          | 8.5                  | 15<br>50                   |     | 10                   | 30<br>100   | nA<br>nA       |
| Average Input Bias Current Drift      |  |          | 50                   | 300                        |     | 100                  | 600         | pA/°C          |
| Differential Input Impedance          |  | 5        | 10                   |                            | 2.5 | 8                    |             | МΩ             |
| Common Mode Input Impedance           |  |          | 2 x 10 <sup>11</sup> |                            |     | 2 x 10 <sup>11</sup> |             | Ω              |
| Supply Current                        | I <sub>L</sub> = 0   |          | 0.9                  | 3.0                        |     | 1.0                  | 4.0         | mA             |
| Power Dissipation                     |  |          | 27                   | 90                         |     | 30                   | 120         | mW             |

# AC Electrical Characteristics TA = 25°C, VS = ±15V

| Parameter              | ameter Conditions   |      | Units  |
|------------------------|---|------|--------|
| Input Noise Voltage    | $R_S = 1 k\Omega$ , $f_O = 10 Hz$   | 11   | nV/√Hz |
|                        | $R_S = 1 k\Omega$ , $f_O = 1 kHz$   | 9    | nV/√Hz |
| Slew Rate              | $A_V = +1, R_L = 10 \text{ k}\Omega, V_{IN} = \pm 10 \text{V}$                              | 0.06 | V/μs   |
| Large Signal Bandwidth | $A_V = \pm 1$ , $R_L = 10 \text{ k}\Omega$ , $V_{IN} = \pm 10 \text{ V}$                    | 1    | kHz    |
| Overload Recovery Time | $A_V = +100, V_{IN} = -100 \text{ mV}, \Delta V_{IN} = 200 \text{ mV}$                      | 5    | μs     |
| Small Signal Bandwidth | $A_V = +1$ , $R_L = 10 k\Omega$   | 400  | kHz    |
| Small Signal Rise Time | $A_V = +1$ , $R_L = 10 \text{ k}\Omega$ , $V_{IN} = 10 \text{ mV}$                          | 2.5  | μs     |
| Overshoot              | $A_V = +1$ , $R_L = 10 \text{ k}\Omega$ , $V_{IN} = 10 \text{ mV}$ , $C_L = 100 \text{ pF}$ | 10   | %      |

Note 1: All specifications apply for all device grades, at  $V_S = \pm 15V$ , and from  $T_{Min}$  to  $T_{Max}$  unless otherwise specified.  $T_{Min}$  is  $-55^{\circ}$ C and  $T_{Max}$  is  $+125^{\circ}$ C for the LH0044.  $T_{Min}$  is  $-25^{\circ}$ C and  $T_{Max}$  is  $+85^{\circ}$ C for the LH0044AC, LH0044B and LH0044C. Typicals are given for  $T_A = 25^{\circ}$ C.

Note 2: This parameter is not 100% tested; however, 90% of the devices are guaranteed to meet this specification after one month of operation and after initial turn-on stabilization.

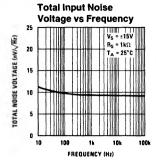
Note 3: Noise is 100% tested on the LH0044AC and LH0044B only. 90% of the LH0044 and LH0044C devices are guaranteed to meet this specification.

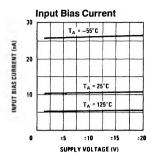
Note 4: The inputs are shunted by back-to-back diodes for over-voltage protection. Excessive current will flow for differential input voltages in excess of 1V. Input current should be limited to less than 1 mA.

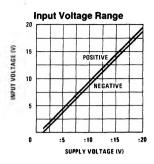
Note 5: For supply voltages less than  $\pm$  15V, the absolute maximum input voltage is equal to the supply voltage.

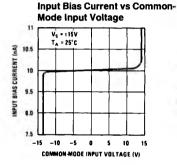
Note 6: Refer to RETS0044AH for LH0044AH military specifications and RETS0044H for LH0044H military specifications.

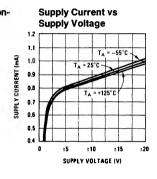
# **Typical Performance Characteristics**

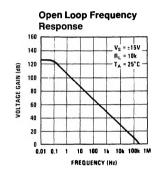


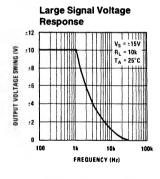


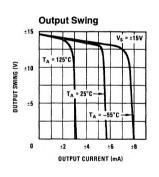


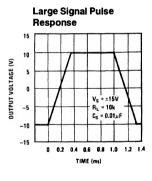


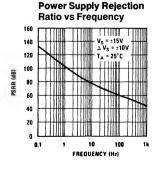


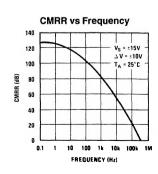


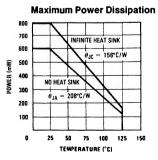












TL/K/5551-3

### **Applications Information**

#### LOW DRIFT CONSIDERATIONS

Achieving ultra-low drift in practical applications requires strict attention to board layout, thermocouple effects, and input guarding. For specific recommendations refer to AN-63 and AN-79.

A point worth stressing with regard to low drift specifications is testing of the LH0044. Simply stated—it is virtually impossible to test the device using a thermoprobe or other form of local heating. A one degree centigrade temperature gradient can account for tens of microvolts of virtual offset (or drift). The test circuit of *Figure 1* is recommended for use in a stabilized oven or continuously stirred oil bath with the entire circuit inside the oven or bath. Isothermal layout of the resistors is advised in order to minimize thermocouple induced EMF's.

#### **OVER COMPENSATION**

The LH0044 may be overcompensated in order to minimize noise bandwidth by paralleling the internal 100 pF capacitor with an external capacitor connected between pins 1 and 6. Unity gain frequency may be predicted by:

$$f = \frac{4 \times 10^{-5}}{100 \text{ pF} + C_{\text{ext}} \text{ pF}} \text{ (Hz)}$$

#### COMPENSATION

For closed loop gains in excess of 10, no external components are required for frequency stability. However, for gains of 10 or less, a  $0.01\mu F$  disc capacitor is recommended between pin 7 (V+) and pin 8 (Comp). An improvement in ac PSRR will also be realized by use of the  $0.01\mu F$  capacitor.

#### **OFFSET NULL**

In general, further nulling of LH0044 is neither necessary nor recommended. For most applications the specified initial offset is sufficient.

However, for those applications requiring additional null, an obvious temptation might be to place a pot between pins 1 and 8 with the wiper returned to V<sup>+</sup>. This technique will usually result in reduced gain and increased offset drift due to mismatch in the TCR of the pot and R1 and R2. The technique is, therefore, not generally recommended.

The recommended technique for offset nulling the LH0044 is shown in *Figure 2*. Null is accomplished in  $A_2$  and all errors are divided by the closed loop gain of the LH0044. Additional offset and drift incurred due to the use of  $A_2$  is less than  $1\mu V/V$  for  $V^+$  and  $V^-$  changes and  $0.01\mu V/^\circ C$  drift for the values shown in *Figure 2*.

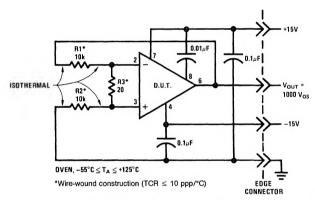


FIGURE 1. LH0044 Temperature Test Circuit

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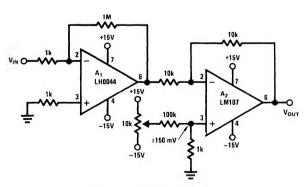
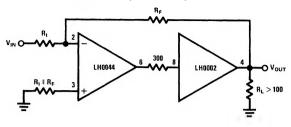


FIGURE 2. LH0044 Null Technique

TL/K/5551-5

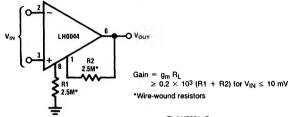
# **Typical Applications**

#### **Buffered Output for Heavy Loads**



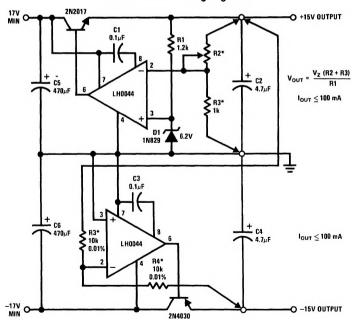
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### X1000 Instrumentation Amp



TL/K/5551-7

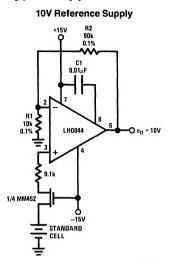
#### **Precision Dual Tracking Regulator**

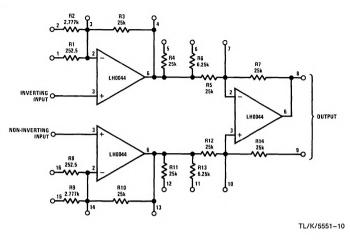


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\*Wire-wound for minimum drift. Line and load regulation  $\leq 0.005\%$ 

# **Typical Applications (Continued)**



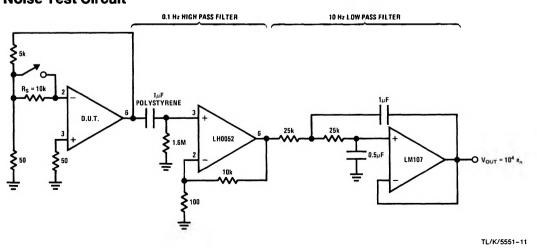


TL/K/5551-9

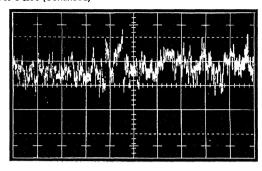
| Precision | Instrumentation | <b>Amplifier</b> |
|-----------|-----------------|------------------|
|-----------|-----------------|------------------|

| Overall<br>Gain | Input Stage<br>Gain | Output Stage<br>Gain |
|-----------------|---------------------|----------------------|
| X1              | X1                  | X1                   |
| X2              | X1                  | X2                   |
| X5              | X1                  | X5                   |
| X10             | X10                 | X1                   |
| X20             | X10                 | X2                   |
| X50             | X10                 | X5                   |
| X100            | X100                | X1                   |
| X200            | X100                | X2                   |
| X500            | X100                | X5                   |
| X995            | X199                | X5                   |

### **Noise Test Circuit**



# Noise Test Circuit (Continued)

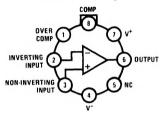


VERT: 200 nV/DIV HORIZ: 5 SEC/DIV

TL/K/5551-12

# **Connection Diagram**

### Metal Can Package



TL/K/5551-2

**Top View** 

Case is electrically isolated

Note: Compensation is not normally required. However, for maximum stability, a  $0.01\mu F$  capacitor should be placed between pins 7 and 8 when device is used below closed loop gains of 10.

Order Number LH0044H, LH0044CH, LH0044ACH or LH0044BH See NS Package Number H08B